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16-PORT LVDS REPEATER

FEATURES

- One Receiver and Sixteen Line Drivers Meet or Exceed the Requirements of ANSI EIA/TIA-644 Standard
- Typical Data Signaling Rates to 400 Mbps or **Clock Frequencies to 400 MHz**
- **Enabling Logic Allows Separate Control of** Each Bank of Four Channels or 2-Bit Selection of Any One of the Four Banks
- Low-Voltage Differential Signaling With Typical Output Voltage of 350 mV and a 100- Ω Load
- **Electrically Compatible With LVDS, PECL,** LVPECL, LVTTL, LVCMOS, GTL, BTL, CTT, SSTL, or HSTL Outputs With External **Termination Networks**
- Propagation Delay Times < 4.7 ns
- Output Skew Is < 300 ps and Part-to-Part Skew < 1.5 ns
- **Total Power Dissipation Typically 470 mW** With All Ports Enabled and at 200 MHz
- **Driver Outputs or Receiver Input Is High** Impedance When Disabled or With $V_{CC} < 1.5$
- **Bus-Pin ESD Protection Exceeds 12 kV**
- Packaged in Thin Shrink Small-Outline Package With 20-Mil Terminal Pitch

DESCRIPTION

The SN65LVDS116 is one differential line receiver connected to sixteen differential line drivers that implement the electrical characteristics of low-voltage differential signaling (LVDS). LVDS, as specified in EIA/TIA-644, is a data signaling technique that offers the low-power, low-noise coupling, and fast switching speeds to transmit data at relatively long distances. (Note: The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media, the noise coupling to the environment, and other system characteristics.)

The intended application of this device and signaling technique is for point-to-point or multidrop baseband data transmission over controlled impedance media of approximately 100 Ω . The transmission media may be printed-circuit board traces, backplanes, or cables. The large number of drivers integrated into the same substrate along with the low pulse skew of balanced signaling, allows extremely precise timing alignment of the signals repeated from the input. This is particularly advantageous in system clock distribution.

The SN65LVDS116 is characterised for operation from -40°C to 85°C.

DGG PACKAGE (TOP VIEW)

| | ı | | 1 | | 1 | |
|----------|---|----|---|----|---|-----|
| GND | d | 1 | U | 64 | Ь | A1Y |
| V_{CC} | 8 | 2 | | 63 | | A1Z |
| V_{CC} | Ц | 3 | | 62 | • | A2Y |
| GND | Ц | 4 | | 61 | • | A2Z |
| ENA | П | 5 | | 60 | | АЗҮ |
| ENA | Ц | 6 | | 59 | • | A3Z |
| NC | 9 | 7 | | 58 | • | A4Y |
| NC | Ц | 8 | | 57 | 0 | A4Z |
| NC | Ц | 9 | | 56 | 0 | B1Y |
| ENB | 9 | 10 | | 55 | • | B1Z |
| ENB | 9 | 11 | | 54 | | B2Y |
| NC | Д | 12 | | 53 | 1 | B2Z |
| NC | 9 | 13 | | 52 | | B3Y |
| NC | Ц | 14 | | 51 | 1 | B3Z |
| GND | Ц | 15 | | 50 | • | B4Y |
| V_{CC} | Д | 16 | | 49 | • | B4Z |
| V_{CC} | Ц | 17 | | 48 | • | C1Y |
| GND | Ц | 18 | | 47 | 1 | C1Z |
| Α | 9 | 19 | | 46 | • | C2Y |
| В | Д | 20 | | 45 | • | C2Z |
| NC | Ц | 21 | | 44 | 1 | C3Y |
| ENC | Q | 22 | | 43 | 0 | C3Z |
| ENC | Д | 23 | | 42 | | C4Y |
| S0 | Ц | 24 | | 41 | 0 | C4Z |
| S1 | 9 | 25 | | 40 | • | D1Y |
| SM | Ц | 26 | | 39 | 1 | D1Z |
| END | Ц | 27 | | 38 | | D2Y |
| END | Д | 28 | | 37 | | D2Z |
| GND | Ц | 29 | | 36 | 1 | D3Y |
| V_{CC} | Ц | 30 | | 35 | р | D3Z |
| V_{CC} | 9 | 31 | | 34 | 0 | D4Y |
| GND | 4 | 32 | | 33 | P | D4Z |
| | | | | | | |



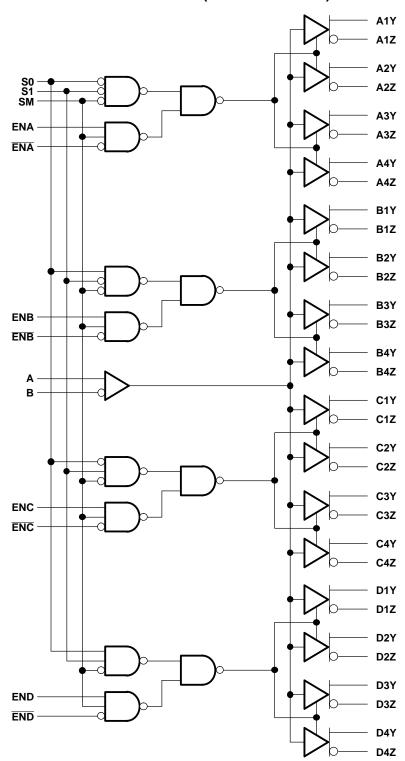
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

LOGIC DIAGRAM (POSITIVE LOGIC)



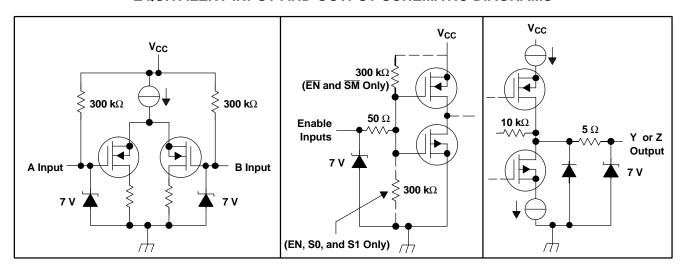


FUNCTION TABLE(1)

| | INPUT | | | | | | | | OUT | PUT | | | |
|------------------------------------|-------|----|----|----|----|----|----|----|-----|-----|----|----|----|
| $V_{ID} = V_A - V_B$ | SM | EN | EN | S1 | S0 | AY | ΑZ | BY | BZ | CY | CZ | DY | DZ |
| Х | Н | L | Х | Х | Х | Z | Z | Z | Z | Z | Z | Z | Z |
| V _{ID} ≥ 100 mV | Н | Н | L | Х | Х | Н | L | Н | L | Н | L | Н | L |
| -100 mV < V _{ID} < 100 mV | Н | Н | L | Х | Х | ? | ? | ? | ? | ? | ? | ? | ? |
| V _{ID} ≤ −100 mV | Н | Н | L | Х | Х | L | Н | L | Н | L | Н | L | Н |
| Х | Н | Χ | Н | Х | Х | Z | Z | Z | Z | Z | Z | Z | Z |
| V _{ID} ≥ 100 mV | L | Χ | Х | L | L | Н | L | Z | Z | Z | Z | Z | Z |
| -100 mV < V _{ID} < 100 mV | L | Χ | Х | L | L | ? | ? | Z | Z | Z | Z | Z | Z |
| V _{ID} ≤ −100 mV | L | Х | Х | L | L | L | Н | Z | Z | Z | Z | Z | Z |
| V _{ID} ≥ 100 mV | L | Х | Х | L | Н | Z | Z | Н | L | Z | Z | Z | Z |
| -100 mV < V _{ID} < 100 mV | L | Χ | Х | L | Н | Z | Z | ? | ? | Z | Z | Z | Z |
| V _{ID} ≤ −100 mV | L | Χ | Х | L | Н | Z | Z | L | Н | Z | Z | Z | Z |
| V _{ID} ≥ 100 mV | L | Χ | Х | Н | L | Z | Z | Z | Z | Н | L | Z | Z |
| -100 mV < V _{ID} < 100 mV | L | Χ | Х | Н | L | Z | Z | Z | Z | ? | ? | Z | Z |
| V _{ID} ≤ −100 mV | L | Х | Х | Н | L | Z | Z | Z | Z | L | Н | Z | Z |
| V _{ID} ≥ 100 mV | L | Χ | Х | Н | Н | Z | Z | Z | Z | Z | Z | Н | L |
| -100 mV < V _{ID} < 100 mV | L | Х | Х | Н | Н | Z | Z | Z | Z | Z | Z | ? | ? |
| $V_{ID} \le -100 \text{ mV}$ | L | Х | Х | Н | Н | Z | Z | Z | Z | Z | Z | L | Н |

⁽¹⁾ H = high level, L = low level, Z = high impedance, ? = indeterminate

EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS





ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)

| | | | UNIT | |
|----------|---------------------------|------------------------------------|------------------------------|--|
| V_{CC} | Supply voltage range (2) | | –0.5 V to 4 V | |
| | Input voltage range | Enable inputs | –0.5 V to 6 V | |
| | Input voltage range | A, B, Y, or Z | –0.5 V to 4 V | |
| | Electrostatic discharge | A, B, Y, Z, and GND ⁽³⁾ | Class 3, A:12 kV, B: 500 V | |
| | Continuous power dissipat | ion | See Dissipation Rating Table | |
| | Storage temperature range | –65°C to 150°C | | |
| | Lead temperature 1,6 mm | 260°C | | |

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

| PACKAGE | T _A ≤ 25°C | DERATING FACTOR ⁽¹⁾ | T _A = 85°C |
|---------|-----------------------|--------------------------------|-----------------------|
| | POWER RATING | ABOVE T _A = 25°C | POWER RATING |
| DGG | 2094 mW | 16.7 mW/°C | 1089 mW |

⁽¹⁾ This is the inverse of the junction-to-ambient thermal resistance when board-mounted (low-k) with no air flow.

RECOMMENDED OPERATING CONDITIONS

| | | MIN | NOM | MAX | UNIT |
|-----------------------------------|---|-----|-----|----------------------|------|
| V _{CC} | Supply voltage | 3 | 3.3 | 3.6 | V |
| V_{IH} | High-level input voltage | 2 | | | V |
| V_{IL} | Low-level input voltage | | | 0.8 | V |
| V_{I} or V_{IC} | Voltage at any bus terminal (separately or common-mode) | 0 | | V _{CC} -0.8 | V |
| T _A | Operating free-air temperature | 40 | | 85 | °C |

²⁾ All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

⁽³⁾ Tested in accordance with MIL-STD-883C Method 3015.7.



ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| | PARAMETER | | TEST CONDITIONS | MIN | TYP ⁽¹⁾ | MAX | UNIT | |
|---------------------|---|----------------------------|---|-------|--------------------|-------|------|--|
| V _{ITH+} | Positive-going differential input voltag | e threshold | Con Figure 1 and Table 1 | | | 100 | mV | |
| V _{ITH} _ | Negative-going differential input volta | ge threshold | See Figure 1 and Table 1 | -100 | | | IIIV | |
| V _{OD} | Differential output voltage magnitude | | D 400 O V 1400V | 247 | 340 | 454 | | |
| $\Delta V_{OD} $ | Change in differential output voltage it tween logic states | magnitude be- | R_L = 100 Ω, V_{ID} = ±100 mV, See Figure 1 and Figure 2 | -50 | | 50 | mV | |
| V _{OC(SS)} | Steady-state common-mode output ve | oltage | | 1.125 | | 1.375 | V | |
| $\Delta V_{OC(SS)}$ | Change in steady-state common-mod age between logic states | de output volt- | See Figure 3 | 50 | | 50 | mV | |
| V _{OC(PP)} | Peak-to-peak common-mode output v | voltage | | | 50 | 150 | | |
| | | | Enabled, $R_L = 100 \Omega$ | | 84 | 115 | A | |
| I _{CC} | | | Disabled, $\overline{ENx} = V_{CC}$ or $ENx = 0 \text{ V}$ | | 3.2 | 6 | mA | |
| | Input current (A or B inputs)(2) | | V _I = 0 V | -2 | | -20 | | |
| I _I | Input current (A or B inputs) (2) | | V _I = 2.4 V | -1.2 | | | μA | |
| I _{I(OFF)} | Power-off input current (A or B inputs | s) | V _{CC} = 1.5 V, V _I = 2.4 V | | | 20 | μA | |
| | High level innut augrent | ENx, S0, S1 | V 2.V | | | 20 | | |
| I _{IH} | High-level input current | ENx, SM | V _{IH} = 2 V | | | -20 | μA | |
| | Low-level input current | ENx, S0, S1 | V = 0.8 V | | | 10 | | |
| I _{IL} | Low-level input current | ENx, SM | $V_{IL} = 0.8 \text{ V}$ | | | -10 | μA | |
| | Short circuit output current | | V_{OY} or $V_{OZ} = 0 V$ | | | ±24 | mA | |
| los | Short-circuit output current | ort-circuit output current | | | | ±12 | ША | |
| l _{OZ} | High-impedance output current | | V _O = 0 V or V _{CC} | | | ±1 | μΑ | |
| I _{O(OFF)} | Power-off output current | · | $V_{CC} = 1.5 \text{ V}, V_{O} = 3.6 \text{ V}$ | | | ±1 | μΑ | |
| C _{IN} | Input capacitance (A or B inputs) | | $V_I = 0.4 \sin (4E6\pi t) + 0.5 V$ | 5 | | | nE | |
| Co | Output capacitance (Y or Z outputs) | | $V_1 = 0.4 \sin(4E6\pi t) + 0.5 V$ | 9.4 | | | pF | |

⁽¹⁾ All typical values are at 25°C and with a 3.3-V supply.

SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP ⁽¹⁾ | MAX | UNIT |
|---------------------|--|--|-----|--------------------|-----|------|
| t _{PLH} | Propagation delay time, low-to-high-level output | | 2.2 | 3.1 | 4.7 | ns |
| t _{PHL} | Propagation delay time, high-to-low-level output | | 2.2 | 3.1 | 4.7 | ns |
| t _r | Differential output signal rise time | | 0.3 | 0.8 | 1.2 | ns |
| t _f | Differential output signal fall time | $R_L = 100 \Omega$, $C_L = 10 pF$, See Figure 4 | 0.3 | 0.8 | 1.2 | ns |
| t _{sk(p)} | Pulse skew (t _{PHL} - t _{PLH}) ⁽²⁾ | | | 140 | 500 | ps |
| t _{sk(o)} | Output skew, channel-to-channel (3) | | | 100 | 300 | ps |
| t _{sk(pp)} | Part-to-part skew ⁽⁴⁾ | | | | 1.5 | ns |
| t _{PZH} | Propagation delay time, high-impedance-to-high-level output | | | 5.7 | 15 | ns |
| t _{PZL} | Propagation delay time, high-impedance-to-low-level output | Coo Figuro F | | 7.7 | 15 | ns |
| t _{PHZ} | Propagation delay time, high-level-to-high-impedance output | See Figure 5 | | 3.2 | 15 | ns |
| t _{PLZ} | Propagation delay time, low-level-to-high-impedance output | | | 3.2 | 15 | ns |

The non-algebraic convention, where the more positive (least negative) limit is designated minimum, is used in this data sheet for the input current (I_I) only.

 ⁽¹⁾ All typical values are at 25°C and with a 3.3-V supply.
 (2) t_{sk(p)} is the magnitude of the time difference between the t_{PLH} and t_{PHL} of any output of a single device.
 (3) t_{sk(o)} is the magnitude of the time difference between the t_{PLH} or t_{PHL} measured at any two outputs.
 (4) t_{sk(pp)} is the magnitude of the time difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.



PARAMETER MEASUREMENT INFORMATION

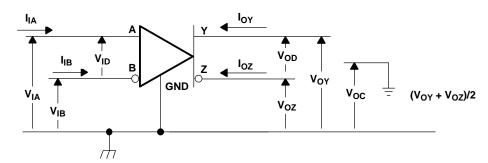


Figure 1. Voltage and Current Definitions

Table 1. Receiver Minimum and Maximum Input Threshold Test Voltages

| APPLIED \ | /OLTAGES | RESULTING DIFFERENTIAL INPUT VOLTAGE | RESULTING COMMON- MODE INPUT VOLTAGE |
|-----------|-----------------|--------------------------------------|---|
| VIA | V _{IB} | V _{ID} | V _{IC} |
| 1.25 V | 1.15 V | 100 mV | 1.2 V |
| 1.15 V | 1.25 V | -100 mV | 1.2 V |
| 2.4 V | 2.3 V | 100 mV | 2.35 V |
| 2.3 V | 2.4 V | -100 mV | 2.35 V |
| 0.1 V | 0 V | 100 mV | 0.05 V |
| 0 V | 0.1 V | -100 mV | 0.05 V |
| 1.5 V | 0.9 V | 600 mV | 1.2 V |
| 0.9 V | 1.5 V | −600 mV | 1.2 V |
| 2.4 V | 1.8 V | 600 mV | 2.1 V |
| 1.8 V | 2.4 V | −600 mV | 2.1 V |
| 0.6 V | 0 V | 600 mV | 0.3 V |
| 0 V | 0.6 V | -600 mV | 0.3 V |

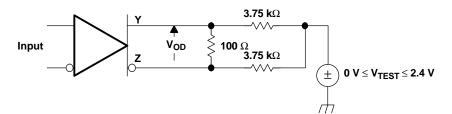
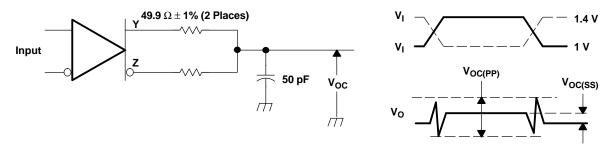


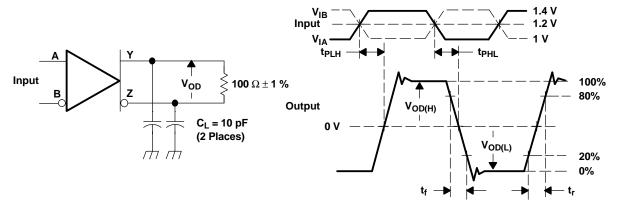
Figure 2. V_{OD} Test Circuit





A. All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 1$ ns, pulse repetition rate (PRR) = 0.5 Mpps, pulse width = 500 ± 10 ns. C_L includes instrumentation and fixture capacitance within 0,06 mm of the D.U.T. The measurement of $V_{OC(PP)}$ is made on test equipment with a -3 dB bandwidth of at least 300 MHz.

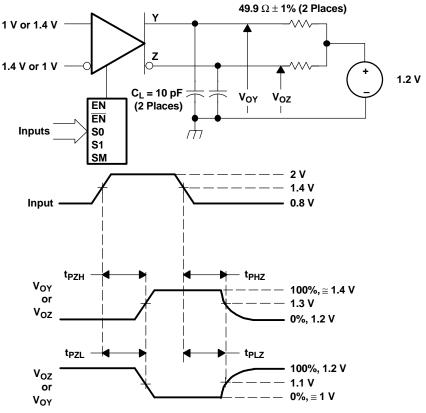
Figure 3. Test Circuit and Definitions for the Driver Common-Mode Output Voltage



A. All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 1$ ns, pulse repetition rate (PRR) = 50 Mpps, pulse width = 10 ± 0.2 ns. C_L includes instrumentation and fixture capacitance within 0,06 mm of the D.U.T.

Figure 4. Test Circuit, Timing, and Voltage Definitions for the Differential Output Signal





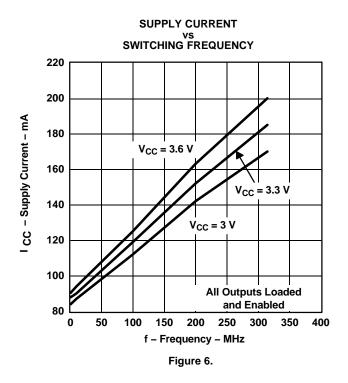
A. All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 1$ ns, pulse repetition rate (PRR) = 0.5 Mpps, pulse width = 500 ± 10 ns. C_L includes instrumentation and fixture capacitance within 0,06 mm of the D.U.T.

Figure 5. Enable and Disable Time Circuit and Definitions

LOW-TO-HIGH PROPAGATION DELAY TIME

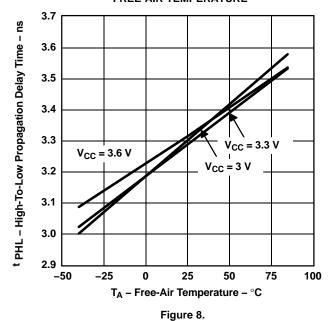


TYPICAL CHARACTERISTICS



vs FREE-AIR TEMPERATURE 3.8 ^t PLH – Low-To-High Propagation Delay Time – ns 3.7 3.6 3.5 V_{CC} = 3.3 V 3.4 $V_{CC} = 3 V$ $V_{CC} = 3.6 \text{ V}$ 3.3 3.2 3.1 -50 25 50 75 100 T_A – Free-Air Temperature – $^{\circ}C$

HIGH-TO-LOW PROPAGATION DELAY TIME vs FREE-AIR TEMPERATURE



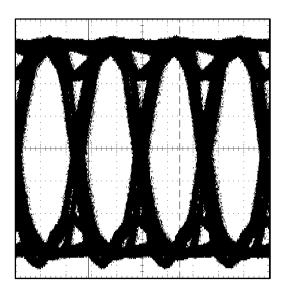
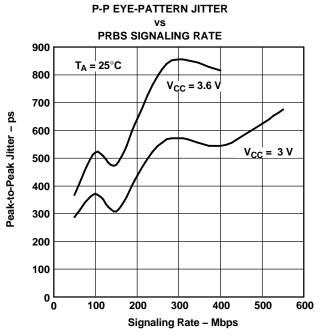


Figure 7.

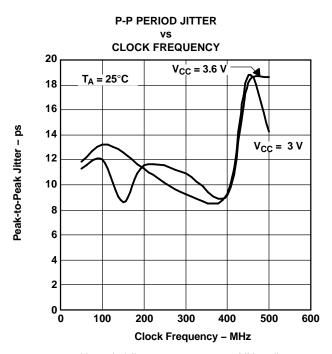
Figure 9. Typical Differential Eye Pattern at 400 Mbps

TYPICAL CHARACTERISTICS (continued)



NOTES: Input: 2^{15} PRBS with peak-to-peak jitter < 115 ps at 100 Mbps, all outputs enabled and loaded with differential $100-\Omega$ loads, worst-case output, supply decoupled with $0.1-\mu F$ and $0.001-\mu F$ ceramic 0805-style capacitors 1 cm from the device.

Figure 10.



NOTES: Input: 50% duty cycle square wave with period jitter < 10 ps at 100 MHz, all outputs enabled and loaded with differential 100-Ω loads, worst-case output, supply decoupled with 0.1-μF and 0.001-μF ceramic 0805-style capacitors 1 cm from the device.

Figure 11.



APPLICATION INFORMATION

FAIL SAFE

A common problem with differential signaling applications is how the system responds when no differential voltage is present on the signal pair. The SN65LVDS116 receiver is like most differential line receivers, in that its output logic state can be indeterminate when the differential input voltage is between –100 mV and 100 mV and within its recommended input common-mode voltage range. Hovever, TI LVDS receivers handle the open-input circuit situation differently.

Open-circuit means that there is little or no input current to the receiver from the data line itself. This could be when the driver is in a high-impedance state or the cable is disconnected. When this occurs, the LVDS receiver pulls each line of the signal pair to near V_{CC} through 300-k Ω resistors as shown in Figure 12. The fail-safe feature uses an AND gate with input voltage thresholds at about 2.3 V to detect this condition and force the output to a high-level regardless of the differential input voltage.

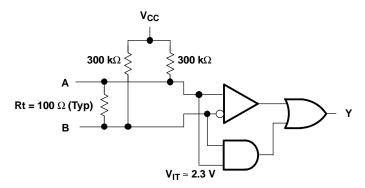


Figure 12. Open-Circuit Fail Safe of the LVDS Receiver

It is only under these conditions that the output of the receiver will be valid with less than a 100 mV differential input voltage magnitude. The presence of the termination resistor, Rt, does not affect the fail-safe function as long as it is connected as shown in Figure 12. Other termination circuits may allow a dc current to ground that could defeat the pullup currents from the receiver and the fail-safe feature.

INPUT LEVEL TRANSLATION

An LVDS receiver can be used to receive various other types of logic signals. Figure 13 through Figure 21 show the termination circuits for SSTL, HSTL, GTL, BTL, LVPECL, PECL, CMOS, and TTL.

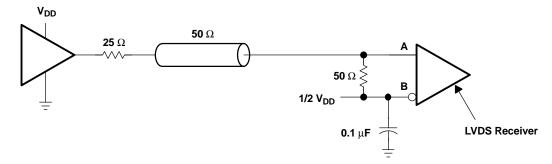


Figure 13. Stub-Series Terminated (SSTL) or High-Speed Transceiver Logic (HSTL)



APPLICATION INFORMATION (continued)

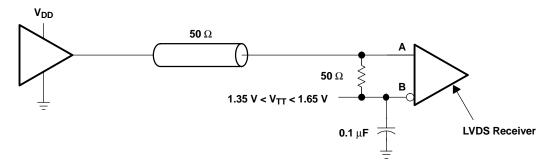


Figure 14. Center-Tap Termination (CTT)

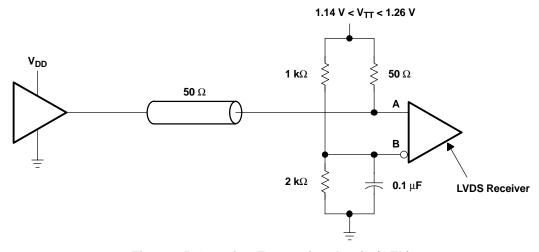


Figure 15. Gunning Transceiver Logic (GTL)

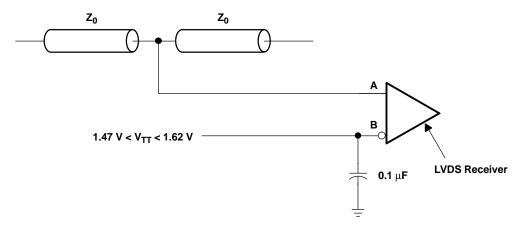


Figure 16. Backplane Transceiver Logic (BTL)



APPLICATION INFORMATION (continued)

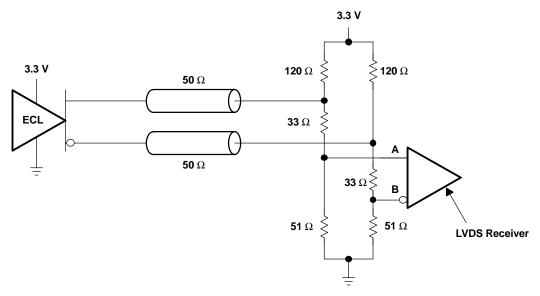


Figure 17. Low-Voltage Positive Emitter-Coupled Logic (LVPECL)

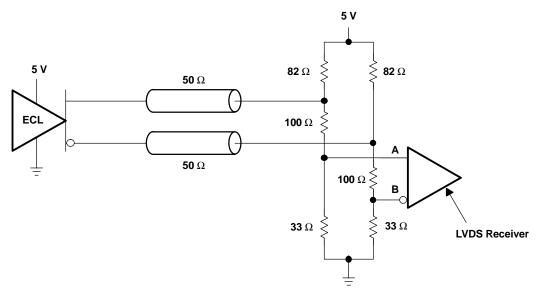


Figure 18. Positive Emitter-Coupled Logic (PECL)



APPLICATION INFORMATION (continued)

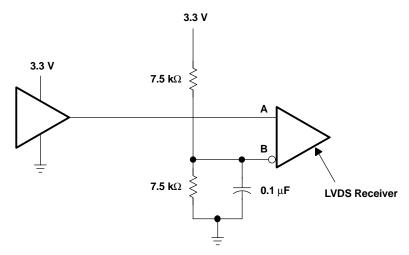


Figure 19. 3.3-V CMOS

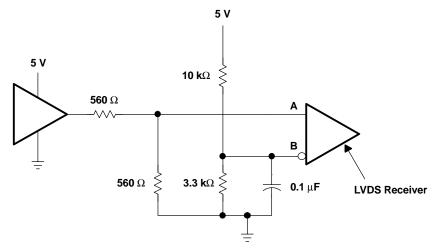


Figure 20. 5-V CMOS

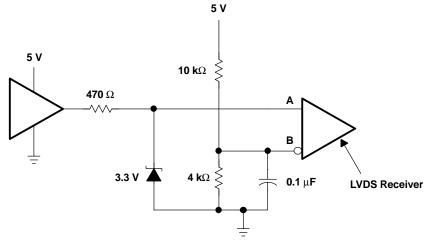


Figure 21. TTL



PACKAGE OPTION ADDENDUM

10-Dec-2020

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|--------------|-------------------------------|---------------------|--------------|----------------------|---------|
| | | | | | | | (6) | | | | |
| SN65LVDS116DGG | ACTIVE | TSSOP | DGG | 64 | 25 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | LVDS116 | Samples |
| SN65LVDS116DGGG4 | ACTIVE | TSSOP | DGG | 64 | 25 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | LVDS116 | Samples |
| SN65LVDS116DGGR | ACTIVE | TSSOP | DGG | 64 | 2000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | LVDS116 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

10-Dec-2020

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN65LVDS116DGGR | TSSOP | DGG | 64 | 2000 | 330.0 | 24.4 | 8.4 | 17.3 | 1.7 | 12.0 | 24.0 | Q1 |

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN65LVDS116DGGR | TSSOP | DGG | 64 | 2000 | 367.0 | 367.0 | 45.0 |

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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